



# CALL FOR PAPERS

**ICMET 2020**  
**Jul 16-17, 2020**  
**Toronto, Canada**

The International Research Conference is a federated organization dedicated to bringing together a significant number of diverse scholarly events for presentation within the conference program. Events will run over a span of time during the conference depending on the number and length of the presentations.

ICMET 2020 : International Conference on Measurement Engineering and Technology is the premier interdisciplinary forum for the presentation of new advances and research results in the fields of Measurement Engineering and Technology. The conference will bring together leading academic scientists, researchers and scholars in the domain of interest from around the world. Topics of interest for submission include, but are not limited to:

Measurement technology  
Instrumentation and measurements  
Instrumentation and measurement technology  
Measurement science and education  
Measurement systems  
Measurement data acquisition  
Measurements of physical quantities  
Measurement applications  
Micro and nano metrology  
In-process and online metrology

Management of measurement processes  
Optical metrology  
Surface metrology  
Machine vision and image processing  
Intelligent instruments for automation  
Sensors and actuators  
Calibration and machine tool performance  
Material characterization  
Education and training in metrology